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| Notice of References Cited | Application/Control No. 09/925,586 | Applicant(s)/Patent Under Reexamination NASSIFF ET AL. | |
| | Examiner Brian J. Broadhead | Art Unit 3661 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-6,434,455 | 08-2002 | Snow et al. | 701/33 |
| | B | US-6,405,126 | 06-2002 | Palomo et al. | 701/202 |
| | C | US-6,405,123 | 06-2002 | Rennard et al. | 701/200 |
| | D | US-6,366,849 | 04-2002 | Rychlak, Stefan | 701/202 |
| | E | US-6,434,458 | 08-2002 | Laguer-Diaz et al. | 701/35 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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